Shenzhen HUAK Testing Technology Co., Ltd. Report No.: HK2007151780-1ER

# TEST REPORT

# ETSI EN 301 489-1 V2.2.3 (2019-11)/ ETSI EN 301 489-3 V2.1.1 (2019-03)/ EN 55032:2015/ EN 55035:2017

Report Reference No...... HK2007151780-1ER

Compiled by

(position+printed name+signature)..: File administrators Gary Qian

Supervised by

( position+printed name+signature)..: Technique principal Leo Zhong

Approved by

( position+printed name+signature)..: Manager James Zhou

Date of issue...... 2020/07/20

Representative Laboratory Name ....: Shenzhen HUAK Testing Technology Co., Ltd.

Heping Community, Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name.....

Address....:

Test specification:

Standard ..... ETSI EN 301 489-1 V2.2.3 (2019-11)/

ETSI EN 301 489-3 V2.1.1 (2019-03)/ EN 55032:2015/ EN 55035:2017

TRF Originator...... Shenzhen HUAK Testing Technology Co., Ltd.

Master TRF...... Dated 2017-05

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Test item description .....: Wireless charging power bank

Trade Mark .....: N/A

Model/Type reference.....: UP-9175 (P322.20)

Listed Models ...... N/A

Hardware Version..... V2.0

Software Version .....: V2.0

Rating ...... Micro USB Input: DC 5V/2A

Typ-C Input: DC 5V/2A USB Ouput 1: DC 5V/1A USB Ouput 2: DC 5V/1A

Wireless Output: DC 5V/1A

Result.....: Positive



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# TEST REPORT

Report No.: HK2007151780-1ER

Test Report No. :	HK2007151780-1ER	2020/07/20
rest Report No	11K2007 131780-1LK	Date of issue

Equipment under Test : Wireless charging power bank

Model /Type : UP-9175 (P322.20)

Listed Models : N/A

Applicant :

Address :

Manufacturer :

Address :

Test Result according to the standards on page 5:	Positive
Standards on page 5.	HIA. HIA.

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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Add: 1/F., Building B2, Junfeng Zhongcheng Zhizao Innovation Park, Heping Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China



# \*\* Modified History \*\*

Report No.: HK2007151780-1ER

Revisio	n	Description	Issued Data	Remark
Revision	1.0	Initial Test Report Release	2020/07/20	James Zhou
TING	TING	TING	-TING	TING TING

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# 1. TEST STANDARDS

The tests were performed according to following standards:

#### ETSI EN 301 489-1 V2.2.3 (2019-11)

ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU and the essential requirements of article 6 of Directive 2014/30/EU

# ETSI EN 301 489-3 V2.1.1 (2019-03)

ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 3: Specific conditions for Short-Range Devices (SRD) operating on frequencies between 9 kHz and 246 GHz; Harmonised Standard covering the essential requirements of article 3.1(b) of Directive 2014/53/EU

EN 55032:2015 Electromagnetic compatibility of multimedia equipment – Emission Requirements

EN 55035:2017 Electromagnetic compatibility of multimedia equipment – Immunity requirements



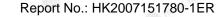
# 2. SUMMARY

# 2.1. General Remarks

Date of receipt of test sample	:	2020/07/15
Testing commenced on	and the	2020/07/15
Testing concluded on	:	2020/07/20

# 2.2. Product Description

Name of EUT	Wireless charging power bank		(48)
Model(s) Number	UP-9175 (P322.20)	All a	TING PILE
List Models	N/A		
Difference descrption	N/A		
Hardware version	V2.0		
Software version	V2.0		
Antenna Type	Coil Antenna		20



# 2.3. Equipment under Test

HUAK TESTING

# Power supply system utilised

Power supply voltage	:	0	120V / 60 Hz	0	115V / 60Hz	22
TESTING		0	12 V DC	0	24 V DC	ESTING
Like.	SER PURI	•	Other (specified in blank bel	ow)	Upit	AND HILDRY

Micro USB Input: DC 5V/2A
Typ-C Input: DC 5V/2A
USB Ouput 1: DC 5V/1A
USB Ouput 2: DC 5V/1A
Wireless Output: DC 5V/1A

# 2.4. Short description of the Equipment under Test (EUT)

For details, refer to the user's manual of EUT.

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# 2.5. EUT operation mode

The equipi	nent under test was operated	daring the	Test Item	or the following con-	ditions.
			rest item		
EMI					
Mode 1	Wireless Charging	TING	TING	TING	TING
EMS					
Mode 1	Wireless Charging				(III)

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# 2.6. EUT configuration

The following peripheral devices and interface cables were connected during the measurement:

- supplied by the manufacturer
- Supplied by the lab

		M/G			- TING	
	TING	MAKTEB		TING	WAY TES	THYG
ette.	HUAKTES	(ii)		UAKTES	(0)	TO HUAK TES
		- MG	(6)		Day	
		MAKTES			MAK TES	

Adapter information N/A

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The test results shall be classified in terms of the loss of function or degradation of performance of the equipment under test relative to a performance criteria defined by its manufacturer or the requestor of the test, or agreed between the manufacturer and the purchaser of the product. Examples of functions defined by the manufacturer to be evaluated during testing include, but are not limited to, the following:

- essential operational modes and states;
- tests of all peripheral access(hard disks, floppy disks, printers, keyboard, mouse, etc.);
- quality of software execution
- quality of data display and transmission
- quality of speech transmission

#### General performance criteria

- based on the used product standard
- based on the declaration of the manufacturer, requestor or purchaser
- performance criteria A for immunity tests with phenomena of a continuous nature;
- performance criteria B for immunity tests with phenomena of a transient nature;
- performance criteria C for immunity tests with power interruptions exceeding a certain time. The equipment shall meet the minimum performance criteria as specified in the following clauses.

#### Performance table

Table 1: Performance criteria

Criteria	During test	After test
Α	Shall operate as intended.	Shall operate as intended.
	May show degradation of performance	Shall be no degradation of performance (see note 2).
	(see note 1).	Shall be no loss of function.
	Shall be no loss of function.	Shall be no loss of stored data or user programmable
В	Shall be no unintentional transmissions.	functions.
В	May show loss of function (one or more).	Functions shall be self-recoverable.
	May show degradation of performance (see note 1).	Shall operate as intended after recovering.  Shall be no degradation of performance (see note 2).
	No unintentional transmissions.	Shall be no loss of stored data or user programmable
	No unintentional transmissions.	functions.
С	May be loss of function (one or more).	Functions shall be recoverable by the operator.
		Shall operate as intended after recovering.
		Shall be no degradation of performance (see note 2).
NOTE 1:		inderstood as a degradation to a level not below a
		anufacturer for the use of the apparatus as intended. In
	of performance.	e level may be replaced by a permissible degradation
	•	sible performance degradation is not specified by the
		ed from the product description and documentation
		e user may reasonably expect from the apparatus if
	used as intended.	, .,
NOTE 2:	No degradation of performance after the test is	understood as no degradation below a minimum
		er for the use of the apparatus as intended. In some
		I may be replaced by a permissible degradation of
		operating data or user retrievable data is allowed.
		sible performance degradation is not specified by the
		ed from the product description and documentation
	(including leaflets and advertising) and what the used as intended.	e user may reasonably expect from the apparatus if
	useu as interiueu.	

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#### Performance criteria for Continuous phenomena applied to Transmitters (CT)

The performance criteria A shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Transient phenomena applied to Transmitters (TT)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Continuous phenomena applied to Receivers (CR)

The performance criteria A shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### Performance criteria for Transient phenomena applied to Receivers (TR)

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply.

Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

#### 2.8. Modifications

No modifications were implemented to meet testing criteria.

# 3. TEST ENVIRONMENT

# 3.1. Address of the test laboratory

Shenzhen HUAK Testing Technology Co., Ltd. 1F, B2 Building, Junfeng Zhongcheng Zhizao Innovation Park, Heping Community, Fuhai Street, Bao'an District, Shenzhen, China

The sites are constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 (2014) and CISPR Publication 22.

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#### 3.2. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature: 15-35 ° C

Humidity: 30-60 %

Atmospheric pressure: 950-1050mbar

# 3.3. Configuration of Tested System

Fig. 2-1 Configuration of Tested System

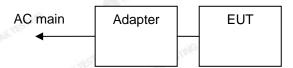


Table 2-1 Equipment Used in Tested System

No.	Product	Manufacturer	Model No.	FCC ID
1 STING	Adapter	HUAWEI	HW-051000CHQ	1

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## 3.4. Test Description

ETSI EN 301 489-1/-3 requirements	March O House	
Radiated Emission	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1 EN 55032: 2015 Annex A.2	PASS
Conducted Emission( AC Mains)	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1	PASS
Conducted Emission( Telcommunication Ports)	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1 EN 55032: 2015 Annex A.3	N/A
Harmonic Current Emissions	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1 EN IEC 61000-3-2: 2019	N/A
Voltage Fluctuations and Flicker	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1 EN 61000-3-3: 2013 + A1:2019	N/A
Conducted Emission (telecommunication)	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.1	N/A
Electrostatic Discharge	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	PASS
RF Electromagnetic Field	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	PASS
Fast Transients Common Mode	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	N/A
RF Common Mode 0,15 MHz to 80 MHz	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	N/A
Transients and Surges	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	N/A
Voltage Dips and Interruptions	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	N/A
Surges, Line to Line and Line to Ground	ETSI EN 301 489-1 V2.2.3 (2019-11) Clause 7.2	N/A

Remark: The measurement uncertainty is not included in the test result.

# 3.5. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods - Part 4: Uncertainty in EMC Measurements" and is documented in the Dongguan Dongdian Testing Service Co., Ltd quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for Dongguan Dongdian Testing Service Co., Ltd is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.24 dB	(1)
Radiated Emission	1~18GHz	5.16 dB	(1)
Radiated Emission	18-40GHz	5.54 dB	(1)
Conducted Disturbance	0.15~30MHz	3.39 dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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Calibra

Dec. 26, 2019 Dec. 25, 2020 1 year

# 3.6. Equipments Used during the Test

## CONDUCTED EMISSION

-57.77							
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration		Calibra tion period
1	LISN	R&S	ENV216	HKE-002	Dec. 26, 2019	Dec. 25, 2020	1 year
2	LISN	R&S	ENV216	HKE-029	Dec. 26, 2019	Dec. 25, 2020	1 year
3	EMI Test Receiver	R&S	ESCI-7	HKE-010	Dec. 26, 2019	Dec. 25, 2020	1 year

#### RADIATED TEST SITE

,,					DESERT.		_
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
1	Broadband antenna	Schwarzbeck	VULB 9163	HKE-012	Dec. 26, 2019	Dec. 25, 2020	1 year
2	EMI Test Receiver	R&S	ESCI-7	HKE-010	Dec. 26, 2019	Dec. 25, 2020	1 year
3	Spectrum analyzer	Agilent	N9020A	HKE-048	Dec. 26, 2019	Dec. 25, 2020	1 year
4	Horn antenna	Schwarzbeck	9120D	HKE-013	Dec. 26, 2019	Dec. 25, 2020	1 year
5	Preamplifie r	EMCI	EMC051845SE	HKE-015	Dec. 26, 2019	Dec. 25, 2020	1 year
6	Preamplifie r	Agilent	83051A	HKE-016	Dec. 26, 2019	Dec. 25, 2020	1 year
7	Position controller	Taiwan MF	MF7802	HKE-011	Dec. 26, 2019	Dec. 25, 2020	1 year

## HARMONICS AND FILCK

li)	Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
	1	Harmonic flicker tester	California Instruments	5001ix	HKE-037	Dec. 26, 2019	Dec. 25, 2020	1 year

## **ESD**

Item	Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	tion period
1	ESD device	Schloder	SESD 216	HKE-023	Dec. 26, 2019	Dec. 25, 2020	1 year
RS		571	IG.		- STING		<u> </u>
Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
1	Signal generator	Agilent	83630A	HKE-028	Dec. 26, 2019	Dec. 25, 2020	1 year
2	Hf antenna	Schwarzbeck	LB-180400-KF	HKE-031	Dec. 26, 2019	Dec. 25, 2020	1 year
3	Power amplifier	R&S	NTWPA- 1060040E	HKE-035	Dec. 26, 2019	Dec. 25, 2020	1 year
4	Broadband antenna	Schwarzbeck	VULB 9163	HKE-012	Dec. 26, 2019	Dec. 25, 2020	1 year
5	Power	P&S	5225E	HKE-058	Dec 26 2010	Dec 25 2020	1 vear

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HKE-058



# SURGE, EFT/BURST, VOLTAGE INTERRUPTION/DIPS

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
STING 1	Full- featured immunity tester	HTEC	HV1P16T	HKE-017	Dec. 26, 2019	Dec. 25, 2020	1 year
2	Group pulse coupling clamp	HTEC	H3C	HKE-024	Dec. 26, 2019	Dec. 25, 2020	1 year

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# INJECTION CURRENT

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
1 <sub>s</sub>	Integrated Conduction Sensitivity Test System	Schloder	CDG6000	HKE-033	Dec. 26, 2019	Dec. 25, 2020	1 year

#### PEME

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibra tion period
1	Power frequency induction coil	HTEC Instruments Ltd.	HPFMF	HKE-049	Dec. 26, 2019	Dec. 25, 2020	1 year



# 4. TEST CONDITIONS AND RESULTS

# 4.1. REQUIREMENTS

## 4.1.1. Radiated Emission

#### LIMIT

Please refer to ETSI EN 301 489-1 Clause 8.2.3

The ancillary equipment shall meet the class B limits given in CENELEC EN 55032 [1], annex A tables A.4 and A.5.

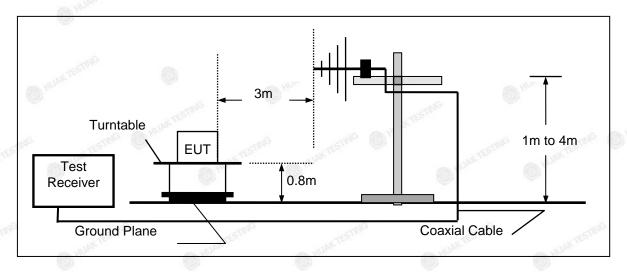
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Alternatively, for ancillary equipment intended to be used exclusively in an industrial environment or telecommunication centres, the class A limits given in CENELEC EN 55032 [1], annex A tables A.2 and A.3 may be used.

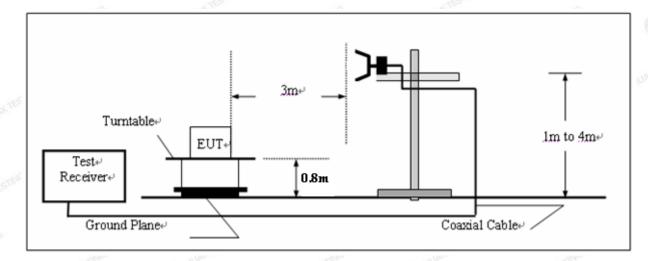
If EUT is also a FM Receiver, it shall meet CENELEC EN 55032 [3], annex A tables A.6

## **TEST CONFIGURATION**

(a) Radiated Emission Test Set-Up, Frequency below 1000MHz



(b) Radiated Emission Test Set-Up, Frequency above 1000MHz





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# **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 8.2.2 and The test method shall be in accordance with CENELEC EN 55032 [1], annex A.2. for the measurement methods.

#### **Climatic conditions**

■ ambient temperature : 25 °C

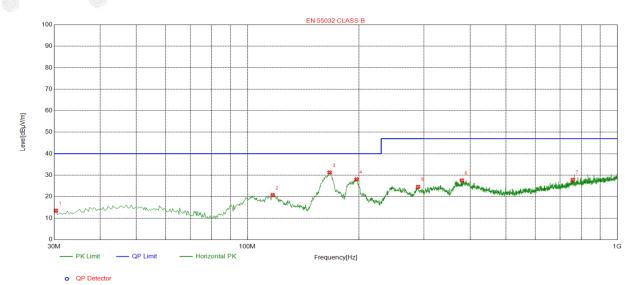
■ relative humidity: 55%

atmospheric pressure: 960 mbar

#### **TEST RESULTS**

## Below 1000MHz

758.3895



Suspe	ected List								
NO	Freq.	Factor	Reading	Level	Limit	Margin	Height	Angle	Delevity
NO.	[MHz]	[dB]	[dBµV/m]	[dBµV/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity
1	30.3234	-16.33	29.80	13.47	40.00	26.53	100	121	Horizontal
2	117.0057	-16.60	37.38	20.78	40.00	19.22	100	336	Horizontal
3	166.8156	-17.59	48.86	31.27	40.00	8.73	100	217	Horizontal
4	197.2191	-15.32	43.42	28.10	40.00	11.90	100	238	Horizontal
5	289.3998	-12.86	37.46	24.60	47.00	22.40	100	223	Horizontal
6	379.9633	-10.83	38.40	27.57	47.00	19.43	100	84	Horizontal

47.00

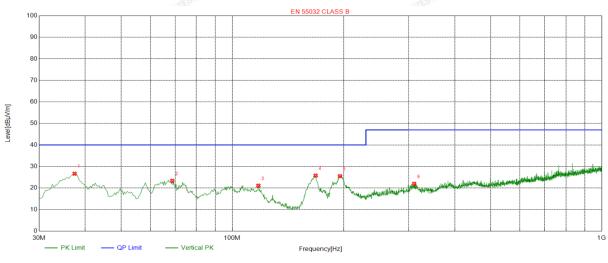
Horizontal

Note: 1. Result Level = Read Level + Antenna Factor + Cable loss.

2. Test setup: RBW: 120 kHz, VBW: 300 kHz, Sweep time: auto.

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Suspe	Suspected List											
NO.	Freq. [MHz]	Factor [dB]	Reading [dBµV/m]	Level [dBµV/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity			
1	37.4391	-15.36	42.02	26.66	40.00	13.34	100	360	Vertical			
2	68.8129	-17.37	40.72	23.35	40.00	16.65	100	139	Vertical			
3	117.6526	-16.71	37.82	21.11	40.00	18.89	100	136	Vertical			
4	168.1094	-17.47	43.25	25.78	40.00	14.22	100	163	Vertical			
5	195.6019	-15.48	40.99	25.51	40.00	14.49	100	133	Vertical			

47.00

21.98

Note: 1. Result Level = Read Level + Antenna Factor + Cable loss.

-12.57

2. Test setup: RBW: 120 kHz, VBW: 300 kHz, Sweep time: auto.

34.55

Remark: Factor = Cable loss + Antenna factor - Preamplifier; Level = Reading + Factor;

Margin = Limit – Level;

310.7469

Radiated Emission From 1 GHz to 6 GHz

EUT highest frequency is less than 108MHz, so this test report is not applicable.



# 4.1.2. Conducted Emission (AC Mains)

# **LIMIT**

Please refer to ETSI EN 301 489-1 Clause 8.4.3

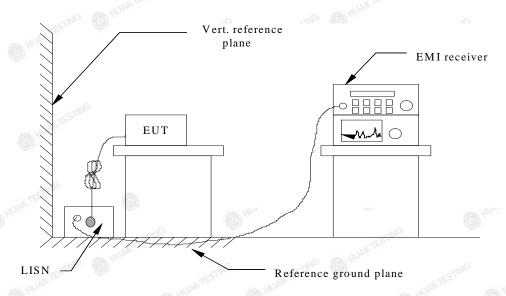
The equipment shall meet the class B limits given in CENELEC EN 55032 [1], annex A table A.10.

Alternatively, for equipment intended to be used in an industrial environment or a telecommunication centre, the class A limits given in CENELEC EN 55032 [1], annex A table A.9 can be used.

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If EUT is also a FM Receiver, it shall meet CENELEC EN 55032 [3], annex A tables A.13

#### **TEST CONFIGURATION**



# **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 8.4.3 and EN 55032 Clause 5 for the measurement methods.

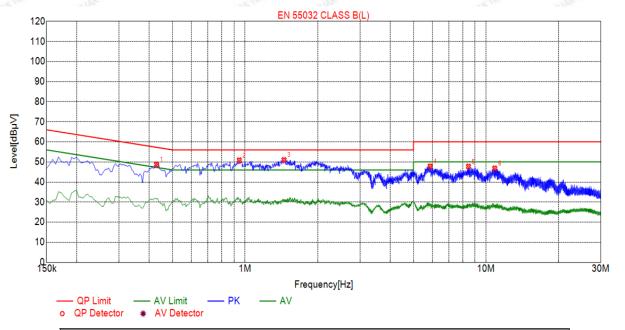
#### **Climatic conditions**

ambient temperature : 25 °C

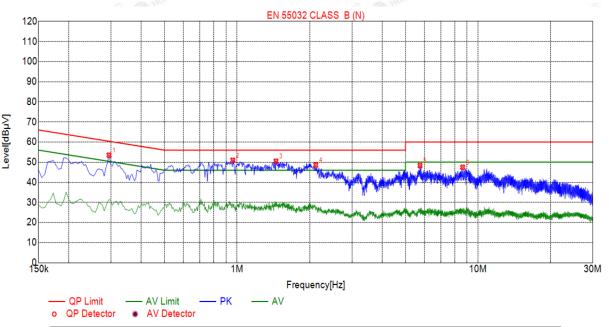
relative humidity: 55%

atmospheric pressure: 960 mbar

# **TEST RESULTS**



Sus	spected	l List						
NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Reading [dBμV]	Detector	Туре
1	0.4290	48.70	10.05	57.27	8.57	38.65	PK	L
2	0.9465	50.87	10.06	56.00	5.13	40.81	PK	L
3	1.4505	51.00	10.10	56.00	5.00	40.90	PK	L
4	5.8605	47.81	10.24	60.00	12.19	37.57	PK	L
5	8.4615	47.74	10.13	60.00	12.26	37.61	PK	L
6	10.8735	46.81	10.02	60.00	13.19	36.79	PK	L



Sus	Suspected List												
NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Reading [dBµV]	Detector	Туре					
1	0.2940	53.48	10.03	60.41	6.93	43.45	PK	N					
2	0.9600	50.95	10.06	56.00	5.05	40.89	PK	N					
3	1.4505	50.47	10.10	56.00	5.53	40.37	PK	N					
4	2.1210	48.60	10.16	56.00	7.40	38.44	PK	N					
5	5.7480	48.31	10.24	60.00	11.69	38.07	PK	N					
6	8.6370	47.48	10.12	60.00	12.52	37.36	PK	N					

Remark: Margin = Limit – Level Correction factor = Cable lose + LISN insertion loss Level=Test receiver reading + correction factor



# 4.1.3. Conducted Emission (Telecommunication Ports)

## LIMIT

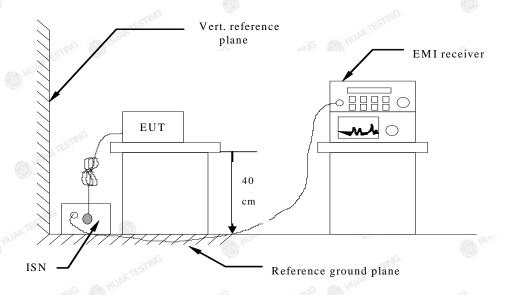
Please refer to ETSI EN 301 489-1 Clause 8.7.3

The wired network ports shall meet the class B limits given in CENELEC EN 55032 [1], annex A table A.12.

Alternatively, for equipment intended to be used exclusively in an industrial environment or a telecommunication centre, the class A limits given in CENELEC EN 55032 [1] annex A table A.11 can be used.

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#### **TEST CONFIGURATION**



## **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 8.7.2 and The test method shall be in accordance with CENELEC EN 55032 [1], annex A.3. for the measurement methods.

# **Climatic conditions**

■ ambient temperature : 25 °C

relative humidity: 55%

atmospheric pressure: 960 mbar

# **TEST RESULTS**

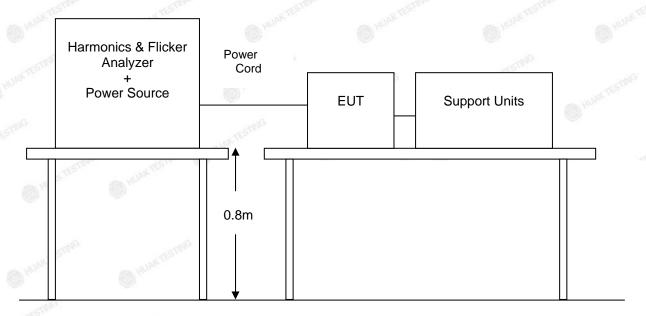
Not applicable

# 4.1.4. Harmonic Current Emission

## LIMIT

Please refer to EN 61000-3-2

# **TEST CONFIGURATION**



# **TEST PROCEDURE**

Please refer to EN 61000-3-2 for the measurement methods.

# Climatic conditions

■ ambient temperature : 25 °C

■ relative humidity: 55%

atmospheric pressure: 960 mbar

# **TEST RESULTS**

N/A

EUT is test by DC power supply, so this test report is not applicable.



# 4.1.5. Voltage Fluctuation and Flicker

#### LIMIT

Please refer to EN 61000-3-3

## **TEST CONFIGURATION**

Same as the configuration of the Harmonic Current Emission.

## TEST PROCEDURE

Please refer to EN 61000-3-3 for the measurement methods.

# **Climatic conditions**

■ ambient temperature : 25 °C

■ relative humidity: 55%

atmospheric pressure: 960 mbar

#### **TEST RESULTS**

N/A

EUT is test by DC power supply, so this test report is not applicable.



# 4.1.6. Electrostatic Discharge

#### LIMIT

Please refer to EN 61000-4-2

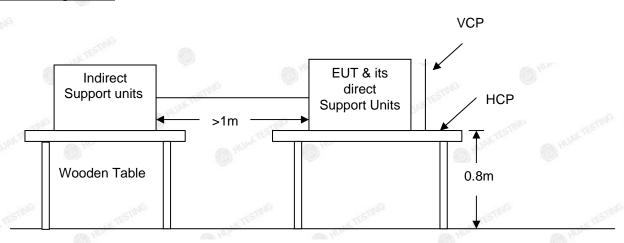
#### SEVERITY LEVELS OF ELECTROSTATIC DISCHARGE

Test level: Contact Discharge at  $\pm 2KV, \pm 4KV$  Air Discharge at  $\pm 2KV, \pm 4KV, \pm 8KV$ 

Level	Test Voltage Contact Discharge (KV)	Test Voltage Air Discharge (KV)  2  4		
1	2			
2	4			
3 1011/125	6	8		
4	8	15		
Х	Special	Special		

Performance criterion: B

#### **Test Configuration**



Ground Reference Plane

#### Test procedure

Please refer to ETSI EN 301 489-1 Clause 9.3.2 and EN 61000-4-2 for the measurement methods.

If EUT is also a FM Receiver, it shall refer to EN 55020:2007/A11:2011 Clause 5.9 for the measurement methods.

#### **Test results**

#### **Contact Discharge:**

The ESD generator is held perpendicular to the surface to which the discharge is applied and the tip of the discharge electrode touch the surface of EUT. Then turn the discharge switch. The generator is then retriggered for a new single discharge and repeated at least 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed



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Air Discharge:

Air discharge is used where contact discharge can't be applied. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated at least 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### Indirect discharge for horizontal coupling plane:

At least 10 single discharges shall be applied to the horizontal coupling plane, at points on each side of the EUT.

#### Indirect discharge for vertical coupling plane:

At least 10 single discharges shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

## **Climatic conditions**

■ ambient temperature : 25°C

■ relative humidity: 55%

atmospheric pressure: 960 mbar

#### Description of the Electrostatic Discharges (ESD)

Point of Discharge	Applied Voltage (KV)	Total No. of Discharge (Each Point)	Results	Criteria Level	Remark
	±2	20	A AK TEB	В	-
Air Test Point	*±4	20	TING A	В	TELLING (III)
MAKTES!	±8	20	Α	IN TEB	UNK I
Contact Discharge	±2	50	Α	В	
Test Points	±4	50	Α	В	
)/OD /4 = '-1= = )	±2	50	Α	В	-
VCP (4 sides)	<u>±4</u>	50	STING A	В	-51°1G
LIOD (4 - 14 STARTE	±2	50	Α	и <sup>ку</sup> В	HUNK I
HCP (4 sides)	±4	50	A	В	<u>-</u>

The requirements are Fulfilled

Performance Criterion: B

Remarks:

The ancillary equipment's specification for an acceptable level of performance or degradation of performance during and/or after the ESD tests.

# **Description of Discharge Point**

Contac	t Discharge	Air Discharge			
0	Metallic Screws	0	Plastic Screws		
0	Metallic Case	•	Plastic Case(gap)		
•	Metallic Connect ports	•	Plastic Connect Ports		
TESTING TEST	Metallic Junctions	TESTING •	Plastic Junctions		
O Marking and a second	Others (Antenna Port)	MINN O MIN	Others		

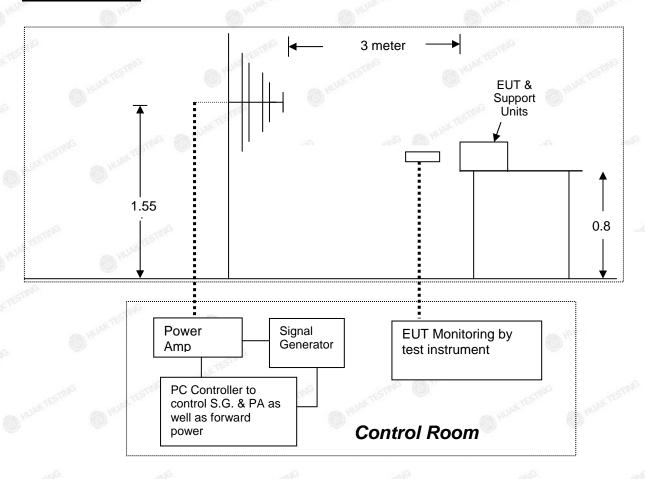


# 4.1.7. RF Electromagnetic Field

# LIMIT

Please refer to EN 61000-4-3

# Test Configuration



# Test Levels of RF Electromagnetic Field

Test level: RF Field Strength: 3V/m

Level	RF Field Strength(V/m)				
1	1	50			
2	TESTING 3	TING			
3	10				
X	Special				

Performance criterion: A

## **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 9.2.2 and EN 61000-4-3 for the measurement methods.



# Climatic conditions

ambient temperature : 25  $\,^{\circ}$ C

relative humidity: 55%

atmospheric pressure: 960 mbar

# **TEST RESULTS**

# Result of Final Tests (Operating Mode & Standby (Receiving) Mode)

	Freq. Range (MHz)	Field	Modulation	Polarity	Position	Mode	Result (Pass/Fail)
- ETING	80-6000	3V/m	Yes	H/V	Front	Co	Pass
1	1800(±1%), 2600(±1%), 3500(±1%), 5000(±1%)	3V/m	Yes	H/V	Front	Normal Operating	Pass
TEST	80-6000	3V/m	Yes	H/V	Right		Pass
2	1800(±1%), 2600(±1%), 3500(±1%), 5000(±1%)	3V/m	Yes	H/V	Right	Normal Operating	Pass
9,0	80-6000	3V/m	Yes	H/V	Back	0,	Pass
JAMETES THE STATE OF THE	1800(±1%), 2600(±1%), 3500(±1%), 5000(±1%)	3V/m	Yes	H/V	Back	Normal Operating	Pass
	80-6000	3V/m	Yes	H/V	Left		Pass
4	1800(±1%), 2600(±1%), 3500(±1%), 5000(±1%)	3V/m	Yes	H/V	Left	Normal Operating	Pass

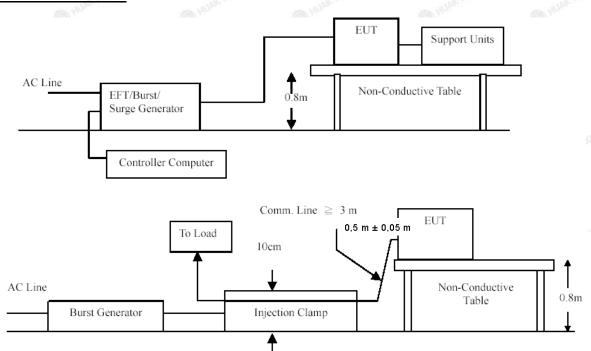


# 4.1.8. Fast Transients Common Mode

## **LIMIT**

Please refer to EN 61000-4-4

#### **TEST CONFIGURATION**



## **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 9.4.2 and EN 61000-4-4 for the measurement methods.

If EUT is also a FM Receiver, it shall refer to EN 55020:2007/A11:2011 Clause 5.6 for the measurement methods.

# Climatic conditions

■ ambient temperature : 25 °C

relative humidity: 55%

atmospheric pressure: 960 mbar

# TEST RESULTS

N/A

EUT is test by DC power supply, so this test report is not applicable.

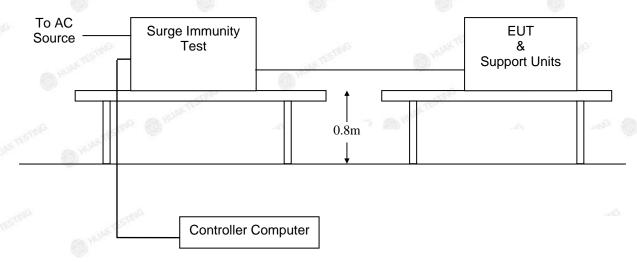


# 4.1.9. Surges, Line to Line and Line to Ground

# LIMIT

Please refer to EN 61000-4-5

# **TEST CONFIGURATION**



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## **TEST PROCEDURE**

Please refer to ETSI EN 301 489-1 Clause 9.4.2 and EN 61000-4-5 for the measurement methods.

## **Climatic conditions**

■ ambient temperature : 25 °C

■ relative humidity: 55%

atmospheric pressure: 960 mbar

# **TEST RESULTS**

N/A

EUT is test by DC power supply, so this test report is not applicable.

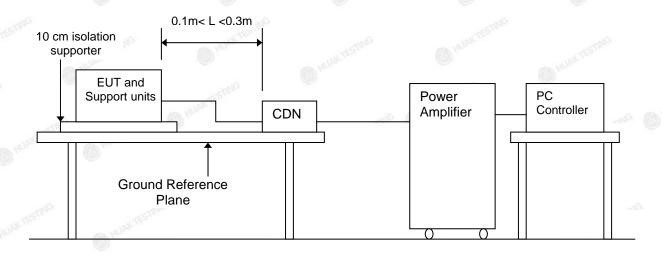


# 4.1.10. RF- Common Mode 0.15MHz to 80MHz

## LIMIT

Please refer to EN 61000-4-6

## **TEST CONFIGURATION**



## TEST PROCEDURE

Please refer to ETSI EN 301 489-1 Clause 9.5.2 and EN 61000-4-6 for the measurement methods.

## **Climatic conditions**

■ ambient temperature : 25 °C

■ relative humidity: 55%

■ atmospheric pressure: 960 mbar

## **TEST RESULTS**

N/A

EUT is test by DC power supply, so this test report is not applicable.

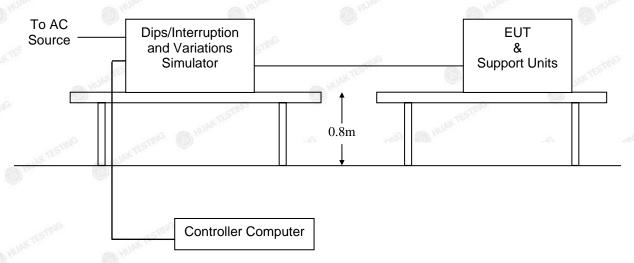


# 4.1.11. Voltage Dips and Interruptions

## LIMIT

Please refer to EN 61000-4-11

## **TEST CONFIGURATION**



# TEST PROCEDURE

Please refer to ETSI EN 301 489-1 Clause 9.7.2 and EN 61000-4-11 for the measurement methods

# **Climatic conditions**

■ ambient temperature : 25 °C

relative humidity: 55%

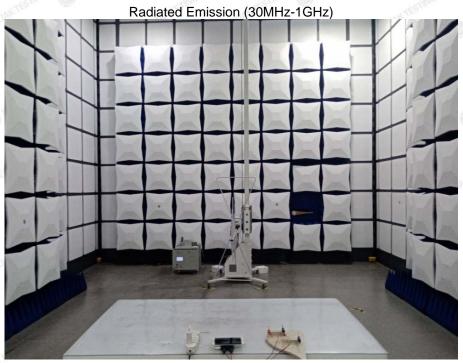
atmospheric pressure: 960 mbar

## **TEST RESULTS**

N/A

EUT is test by DC power supply, so this test report is not applicable.

# 5. Test Set-up Photos of the EUT



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Conducted Emission



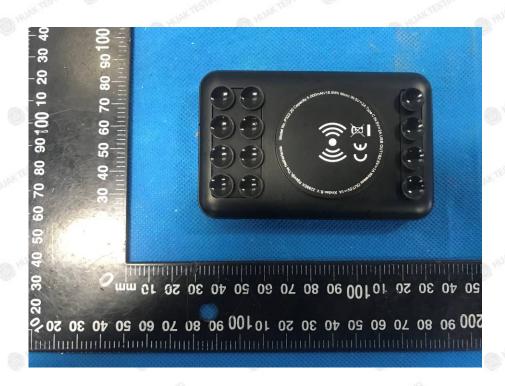






# 6. PHOTOS OF THE EUT











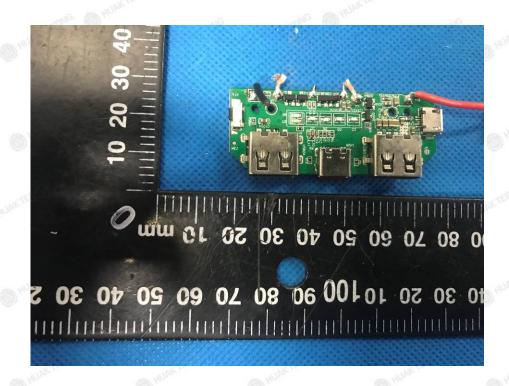


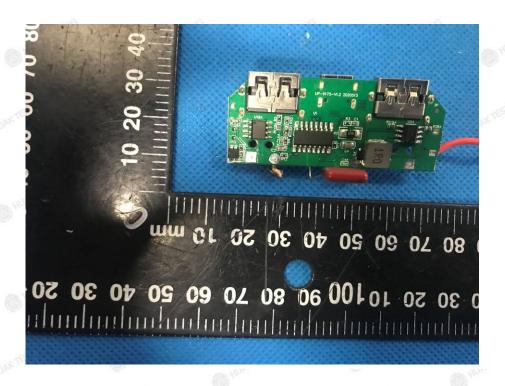


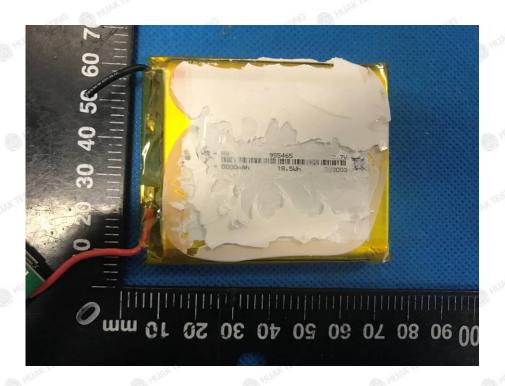












.....End of Report.....